



ALPHA & OMEGA
SEMICONDUCTOR

AOD2922

100V N-Channel AlphaMOS

General Description

- Latest Trench Power AlphaMOS (α MOS MV) technology
- Very Low $R_{DS(ON)}$
- Low Gate Charge
- Optimized for fast-switching applications
- RoHS and Halogen-Free Compliant

Product Summary

V_{DS}	100V
I_D (at $V_{GS}=10V$)	7A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 140m Ω
$R_{DS(ON)}$ (at $V_{GS}=4.5V$)	< 176m Ω

Application

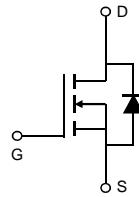
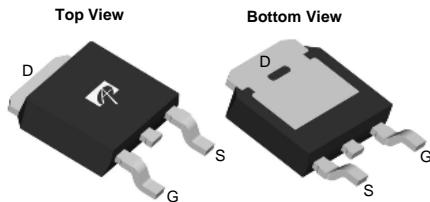
- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

100% UIS Tested

100% R_g Tested



TO-252
DPAK



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOD2922	TO-252	Tape & Reel	2500

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_C=25^\circ\text{C}$ $T_C=100^\circ\text{C}$	I_D	A
Pulsed Drain Current ^C	I_{DM}	10	
Continuous Drain Current	$T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	I_{DSM}	A
Avalanche Current ^C	I_{AS}	3	
Avalanche energy L=0.1mH ^C	E_{AS}	0.5	mJ
V_{DS} Spike	10us	V_{SPIKE}	V
Power Dissipation ^B	$T_C=25^\circ\text{C}$ $T_C=100^\circ\text{C}$	P_D	W
		8.5	
Power Dissipation ^A	$T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	P_{DSM}	W
		5.0	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$t \leq 10\text{s}$ Steady-State	20	25	°C/W
Maximum Junction-to-Ambient ^{A,D}		40	50	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	7.3	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		1	5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$			±100	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.7	2.2	2.7	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=5\text{A}$ $T_J=125^\circ\text{C}$	117	140	224	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=3\text{A}$	140	176	270	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=5\text{A}$		8.5		S
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.8	1.1	V
I_S	Maximum Body-Diode Continuous Current				7	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=50\text{V}, f=1\text{MHz}$		250	310	pF
C_{oss}	Output Capacitance			19	30	pF
C_{rss}	Reverse Transfer Capacitance			2.5	8	pF
R_g	Gate resistance	f=1MHz	5	10.5	16	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=5\text{A}$		3.8	10	nC
$Q_g(4.5\text{V})$	Total Gate Charge			1.8	6	nC
Q_{gs}	Gate Source Charge			0.8		nC
Q_{gd}	Gate Drain Charge			0.8		nC
$t_{D(\text{on})}$	Turn-On DelayTime	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, R_L=10\Omega, R_{\text{GEN}}=3\Omega$		5		ns
t_r	Turn-On Rise Time			3		ns
$t_{D(\text{off})}$	Turn-Off DelayTime			19		ns
t_f	Turn-Off Fall Time			5		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=5\text{A}, dI/dt=500\text{A}/\mu\text{s}$		16		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=5\text{A}, dI/dt=500\text{A}/\mu\text{s}$		52		nC

A. The value of R_{QJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{\text{QJA}} \approx 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$.

D. The R_{QJA} is the sum of the thermal impedance from junction to case R_{QJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

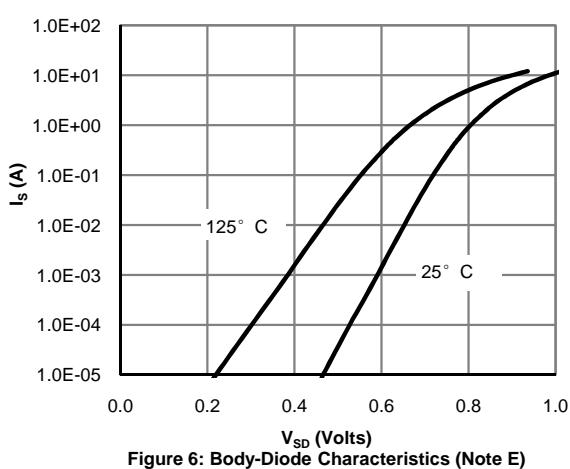
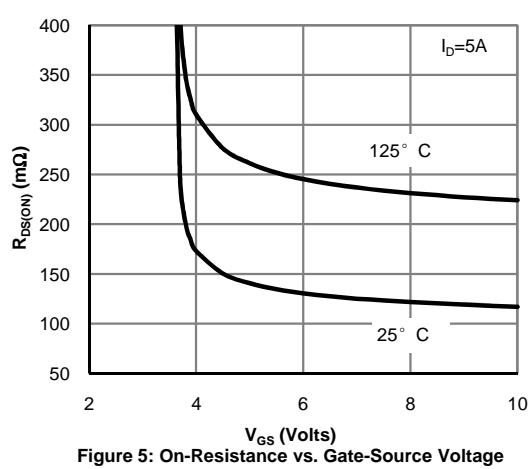
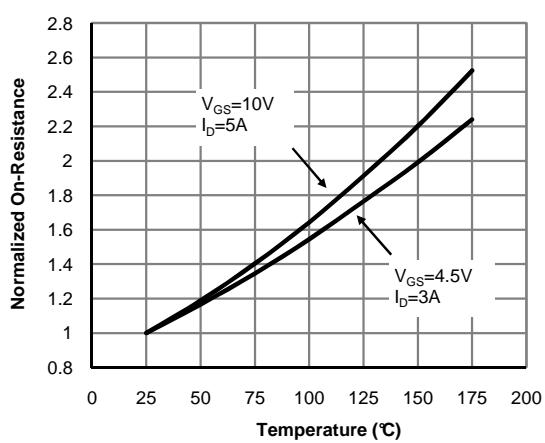
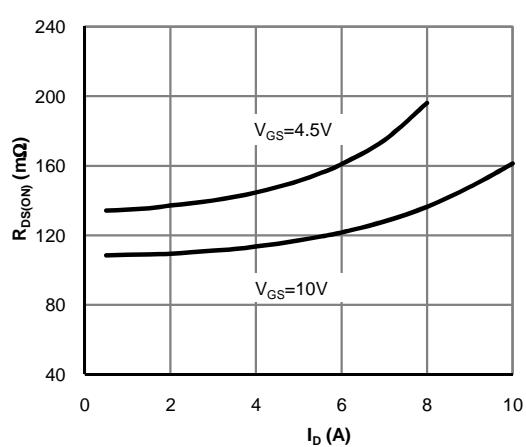
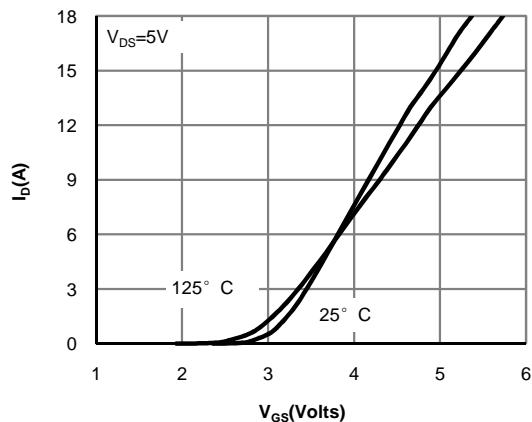
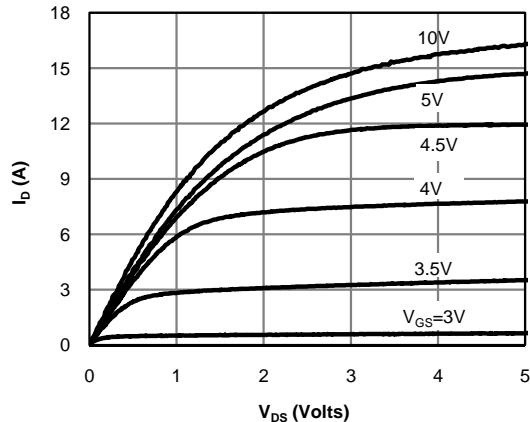
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$. The SOA curve provides a single pulse rating.

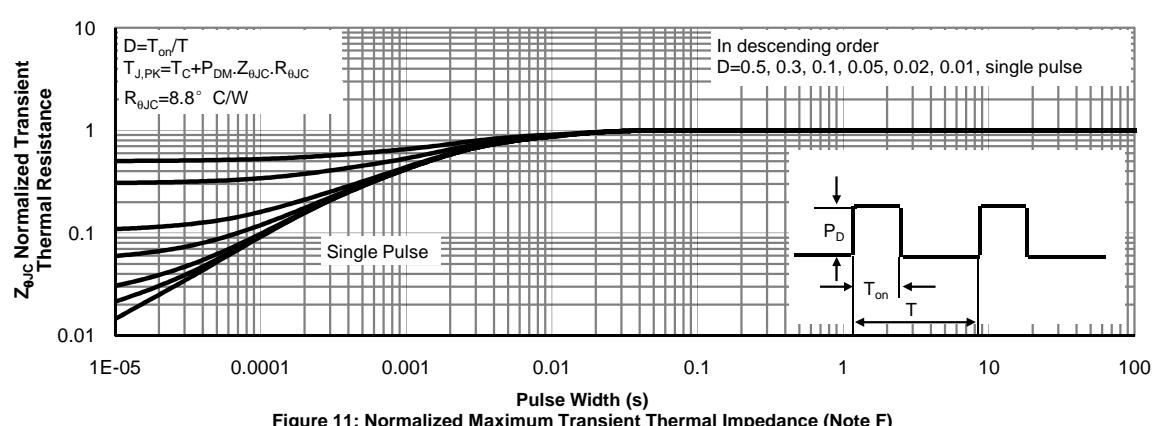
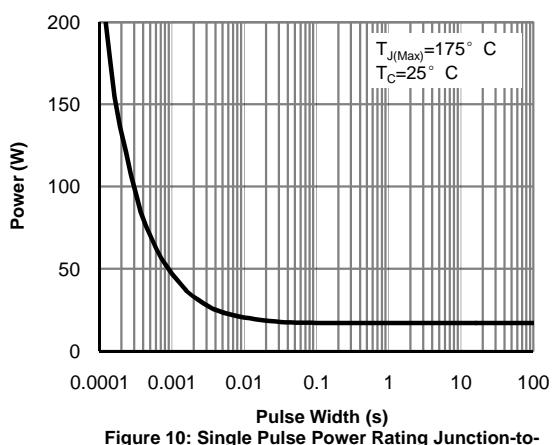
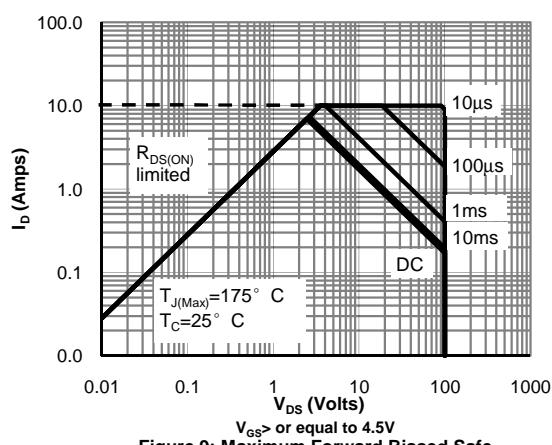
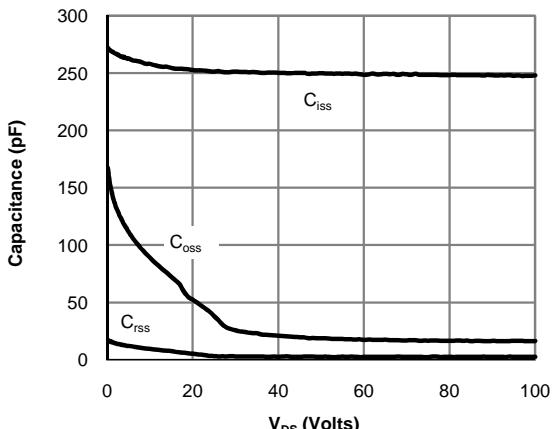
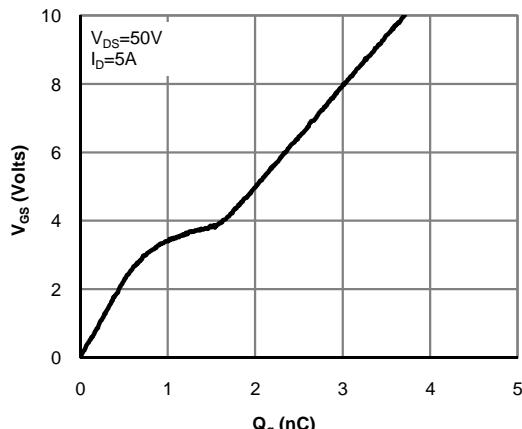
G. The maximum current rating is package limited.

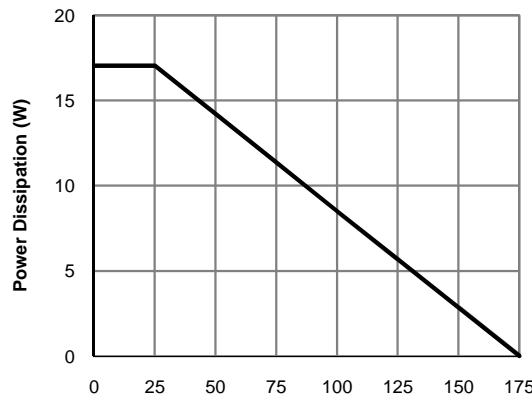
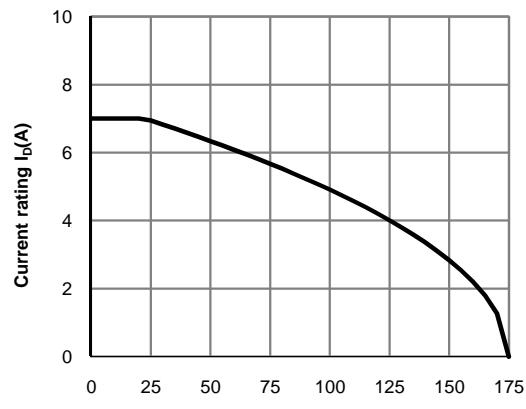
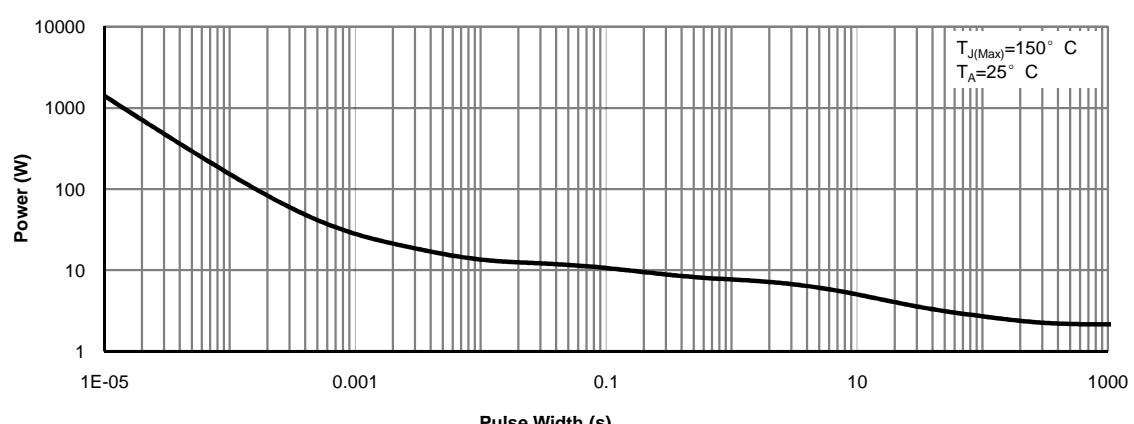
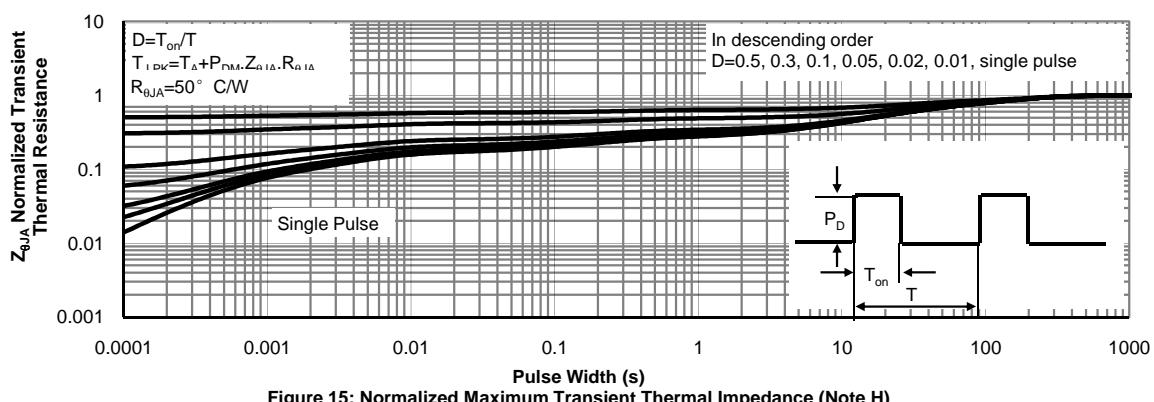
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

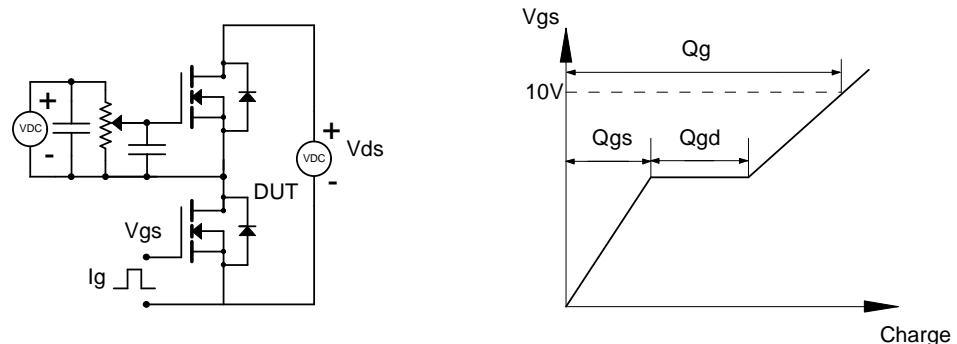
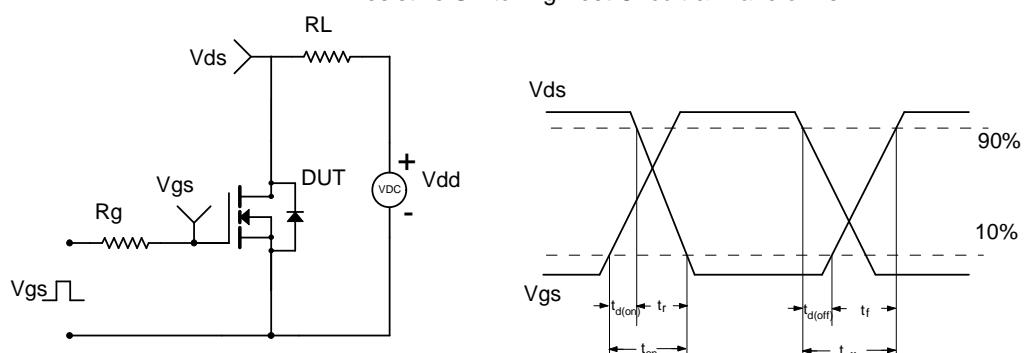
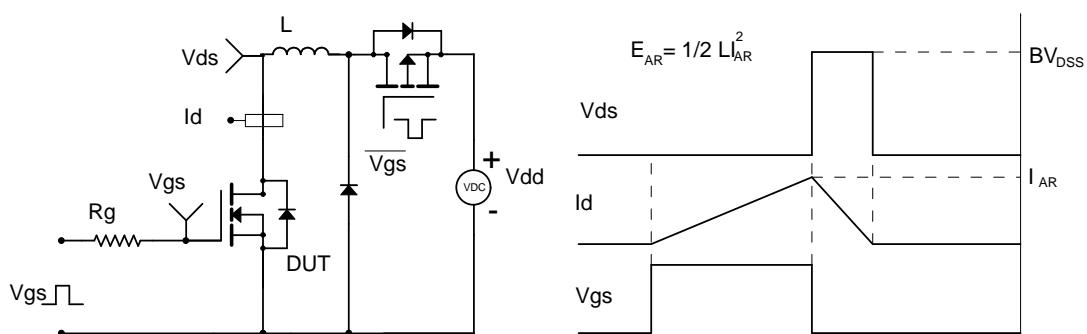
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
